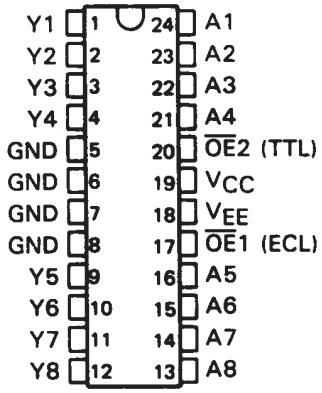
SDZS001A – D3136, AUGUST 1988 – REVISED DECEMBER 1988

- **10KH Compatible**
- **ECL and TTL Control Inputs**
- **P-N-P Inputs Reduce DC Loading**
- **Flow-Through Architectures Optimizes PCB Layout**
- **Center Pin V_{CC}, V_{EE} and GND Configurations Minimize High-Speed Switching Noise**
- **ESD Protection Exceeds 2000 V Per MIL-STD-883C, Method 3015**
- **Package Options Include "Small Outline" Packages and Standard Plastic 300-mil DIPs**

DW OR NT PACKAGE
(TOP VIEW)



description

These octal TTL-to-ECL translators are designed to provide efficient translation between a TTL signal environment and a 10KH ECL signal environment. The designer has a choice of inverting ('5542) or true ('5543) outputs. Two pins, $\overline{OE}1$ and $\overline{OE}2$, are provided for output enable control. These control inputs are negative ANDed together, with $\overline{OE}1$ being ECL compatible and $\overline{OE}2$ being TTL compatible. This offers the choice of controlling the outputs of the device from either a TTL or ECL signal environment. The outputs, when disabled, go to a normal ECL logic low level.

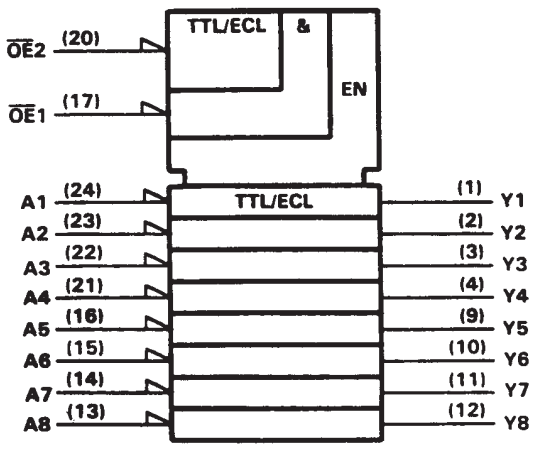
The SN10KHT5542 and SN10KHT5543 are characterized for operation from 0°C to 75°C.

FUNCTION TABLE

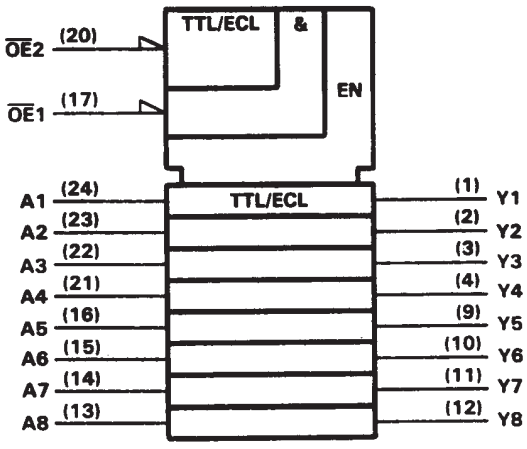
OUTPUT CONTROL		DATA INPUT	OUTPUT	
$\overline{OE}1$	$\overline{OE}2$	A	'5542	'5543
H	X	X	L	L
X	H	X	L	L
L	L	L	H	L
L	L	H	L	H

logic symbols†

SN10KHT5542



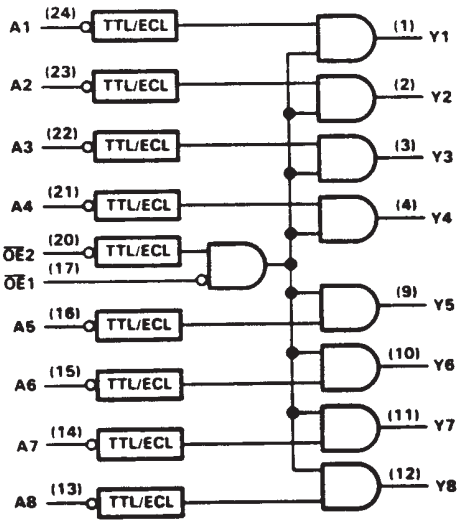
SN10KHT5543



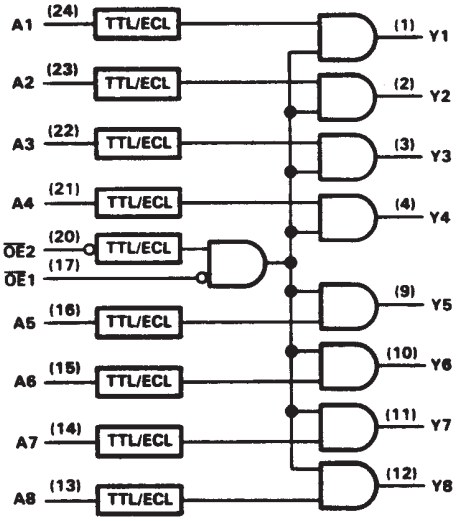
†These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagrams (positive logic)

SN10KHT5542



SN10KHT5543



absolute maximum ratings over operating ambient temperature range (unless otherwise noted)†

Supply voltage range, V_{CC} . . . . . −0.5 V to 7 V
Supply voltage range, V_{EE} . . . . . −8 V to 0 V
Input voltage range (TTL) (See Note 1) . . . . . −1.2 V to 7 V
Input voltage range (ECL) . . . . . V_{EE} to 0 V
Input current range (TTL) . . . . . −30 mA to 5 mA
Operating ambient temperature range . . . . . 0°C to 75°C
Storage temperature range . . . . . −65°C to 150°C

†Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTE 1: The input voltage ratings may be exceeded provided the input current ratings are observed.

recommended operating conditions (see Note 2)

			MIN	NOM	MAX	UNIT
V_{CC}	TTL supply voltage		4.5	5.0	5.5	V
V_{EE}	ECL supply voltage		−4.94	−5.2	−5.46	V
V_{IH}	TTL high-level input voltage		2			V
V_{IH}	ECL high-level input voltage‡	0°C	−1170		−840	mV
		25°C	−1130		−810	
		75°C	−1070		−735	
V_{IL}	TTL low-level input voltage				0.8	V
V_{IL}	ECL low-level input voltage‡	0°C	−1950		−1480	mV
		25°C	−1950		−1480	
		75°C	−1950		−1450	
I_{IK}	TTL input clamp current				−18	mA
T_A	Operating ambient temperature (see Note 3)		0		75	°C

‡The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic voltage levels and temperature only.

NOTES: 2. If unused, $\overline{OE}1$ should be tied directly to −2 V.

3: Each 10KH series circuit has been designed to meet the dc specifications shown in the electrical characteristics table after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board, and transverse air flow greater than 500 linear ft/min is maintained.

electrical characteristics over recommended operating ambient temperature range (unless otherwise noted) (see Note 2)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT
V_{IK}	A inputs and $\overline{OE}2$	V_{CC} = 4.5 V, V_{EE} = −4.94 V, I_I = −18 mA				−1.2	V
I_I	A inputs and $\overline{OE}2$	V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = 7 V				0.1	mA
I_{IH}	A inputs and $\overline{OE}2$	V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = 2.7 V				20	μA
	$\overline{OE}1$ only	V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = −840 mV	0°C			350	
		V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = −810 mV	25°C			350	
		V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = −735 mV	75°C			350	
I_{IL}	A inputs and $\overline{OE}2$	V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = 0.5 V				−500	μA
	$\overline{OE}1$ only	V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = −1950 mV	0°C	0.5			
			25°C	0.5			
			75°C	0.5			
V_{OH}‡		V_{CC} = 4.5 V, V_{EE} = −5.2 V, ±5%, See Note 3	0°C	−1020		−840	mV
			25°C	−980		−810	
			75°C	−920		−735	
V_{OL}‡		V_{CC} = 4.5 V, V_{EE} = −5.2 V, ±5%, See Note 3	0°C	−1950		−1630	mV
			25°C	−1950		−1630	
			75°C	−1950		−1600	
I_{CCH}		V_{CC} = 5.5 V, V_{EE} = −5.46 V			15	22	mA
I_{CCL}		V_{CC} = 5.5 V, V_{EE} = −5.46 V			17	25	mA
I_{EE}		V_{CC} = 5.5 V, V_{EE} = −5.46 V			−78	−111	mA
C_i		V_{CC} = 5 V, V_{EE} = −5.2 V, f = 10 MHz			5		pF

switching characteristics over recommended ranges of operating ambient temperature and supply voltage (unless otherwise noted) (see Note 4)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP†	MAX	UNIT
t_{PLH}	Any A	Y	0.1	1.7	3.7	ns
t_{PHL}			0.1	1.6	3.3	
t_{PLH}	$\overline{OE}1$ (ECL)	Y	0.8	2.8	5	ns
t_{PHL}			0.4	2.3	4.5	
t_{PLH}	$\overline{OE}2$ (TTL)	Y	0.8	3	5.3	ns
t_{PHL}			0.6	2.5	4.7	
t_r		Y		1.5		ns
t_f				1.5		

† All typical values are at V_{CC} = 5 V, V_{EE} = −5.2 V, T_A = 25°C.

‡ The algebraic convention, in which the least positive (most negative) value is designated minimum, is used in this data sheet for logic voltage levels and temperature only.

NOTES: 2. Each 10KH series circuit has been designed to meet the dc specifications shown in the electrical characteristics table after thermal equilibrium has been established. The circuit is in a test socket or mounted on a printed circuit board and transverse air flow greater than 500 linear ft/min is maintained.

3. Outputs are terminated through a 50-Ω resistor to −2 V.

4. Load circuit and switching waveforms are shown in Section 1.

electrical characteristics over recommended operating ambient temperature range (unless otherwise noted) (see Note 2)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT
V_{IK}	A inputs and $\overline{OE}2$	V_{CC} = 4.5 V, V_{EE} = −4.94 V, I_I = −18 mA				−1.2	V
I_I	A inputs and $\overline{OE}2$	V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = 7 V				0.1	mA
I_{IH}	A inputs and $\overline{OE}2$	V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = 2.7 V				20	μA
	$\overline{OE}1$ only	V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = −840 mV	0°C			350	μA
		V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = −810 mV	25°C			350	μA
		V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = −735 mV	75°C			350	μA
I_{IL}	A inputs and $\overline{OE}2$	V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = 0.5 V				−500	μA
	$\overline{OE}1$ only	V_{CC} = 5.5 V, V_{EE} = −5.46 V, V_I = −1950 mV	0°C	0.5			μA
			25°C	0.5			μA
			75°C	0.5			μA
V_{OH}‡		V_{CC} = 4.5 V, V_{EE} = −5.2 V, ±5%, See Note 3	0°C	−1020		−840	mV
			25°C	−980		−810	mV
			75°C	−920		−735	mV
V_{OL}‡		V_{CC} = 4.5 V, V_{EE} = −5.2 V, ±5%, See Note 3	0°C	−1950		−1630	mV
			25°C	−1950		−1630	mV
			75°C	−1950		−1600	mV
I_{CCH}		V_{CC} = 5.5 V, V_{EE} = −5.46 V			17	25	mA
I_{CCL}		V_{CC} = 5.5 V, V_{EE} = −5.46 V			15	22	mA
I_{EE}		V_{CC} = 5.5 V, V_{EE} = −5.46 V			−77	−111	mA
C_i		V_{CC} = 5 V, V_{EE} = −5.2 V, f = 10 MHz			5		pF

switching characteristics over recommended ranges of operating ambient temperature and supply voltage (unless otherwise noted) (see Note 4)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	MIN	TYP†	MAX	UNIT
t_{PLH}	Any A	Y	0.1	1.5	3	ns
t_{PHL}			0.1	1.5	3.3	ns
t_{PLH}	$\overline{OE}1$ (ECL)	Y	0.6	2.2	4.3	ns
t_{PHL}			0.5	2.4	4.3	ns
t_{PLH}	$\overline{OE}2$ (TTL)	Y	0.7	2.2	4.4	ns
t_{PHL}			0.5	2.6	4.7	ns
t_r		Y		1.5		ns
t_f				1.5		ns

† All typical values are at V_{CC} = 5 V, V_{EE} = −5.2 V, T_A = 25°C.

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3. Outputs are terminated through a 50-Ω resistor to −2 V.

4. Load circuit and voltage waveforms are shown in Section 1.

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